

View Online at https://aerobasegroup.com/nsn/5910-01-375-5073

Body Style:	
Chip type	
Reliability Indica	tor:
Established	
Reliability Failur	e Rate Level In Percent:
0.001	
Terminal Length	
0.5 millimeters	
Body Length:	
3.2 millimeters	
Body Width:	
2.5 millimeters	
Body Height:	
1.5 millimeters	
Schematic Diagr	am Designator:
No common or gr	bunded electrode (s)
Insulation Resist	ance At Maximum Operating Temp:
10000.0 megohm	8
Capacitance Val	e Per Section:
100000.000 picof	arads single section
Voltage Tempura	ture Limits Per Section In Percent Capacitance Change:
-25.0/+15.0 with r	ated voltage applied single section
Nonderated Ope	rating Temp:
Between -55.0 de	grees celsius and 125.0 degrees celsius
Nonderated Con	inuous Voltage Rating And Type Per Section:
50.0 dc single seo	tion
Tolerance Range	Per Section:
-10.00/+10.00 per	cent single section
Case Material:	
Ceramic	
Insulation Resist	ance At Reference Temp:
100000.0 megohr	ns
Dissipation Fact	or At Reference Tempurature In Percent:
2.500	
Terminal Surface	Treatment:
Silver and palladi	Im
Precious Materia	I And Location:
Terminals silver a	nd terminals surfaces palladium
Test Data Docun	ent:
81349-mil-c-5568	I specification (includes engineering type bulletins, brochures, etc., that reflect specification type data in specification
format; excludes	commercial catalogs, industry directories, and similar trade publications, reflecting general type data on certain
environmental an	performance requirements and test conditions that are shown as "typical", "average", "", etc.).

Terminal Type And Quantity:

2 bonding pad



Specification Data:

81349-mil-c-55681/9 government specification

Shelf Life:

N/a

Unit Of Measure:

Demilitarization:

No

Fiig:

A010b0